Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination OGAWA ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,570,472	02-1986	Kuwano, Hiroaki	72/8.4
*	В	US-5,267,170	11-1993	Anbe, Yoshiharu	700/154
*	C	US-5,279,139	01-1994	Sturm, Hans	72/13.4
*	D	US-4,320,643	03-1982	Yasuda et al.	72/10.6
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	2	JP 2002210513 A	07-2002	Japan	ETO et al.	
	0					
	Р					
	Q					
	R					·
	S					
:	Т					

NON-PATENT DOCUMENTS

_		
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.